Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/669,098	ISHIKAWA ET AL.
Examiner	Art Unit
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Erin D. Chiem	2883

SEARCHED				
Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
See attached search notes for updated search	12/20/2005	EDC		